FAIRCHILD

SEMICONDUCTOR®

FQD6N50C / FQU6N50C N-Channel QFET MOSFET 500 V, 4.5 A, 1.2 Ω

Description

This N-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor®'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

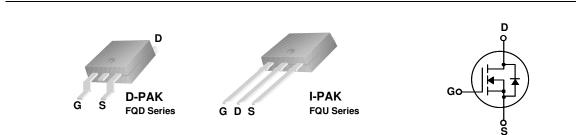
Features

+ 4.5 A, 500 V, ${\sf R}_{\sf DS(on)}$ = 1.2 Ω (Max) @V_{\sf GS} = 10 V, ${\sf I}_{\sf D}$ = 2.25 A

FQD6N50C / FQU6N50C N-Channel MOSFET

March 2013

- Low Gate Charge (Typ. 19 nC)
- Low Crss (Typ. 15 pF)
- 100% Avalanche Tested



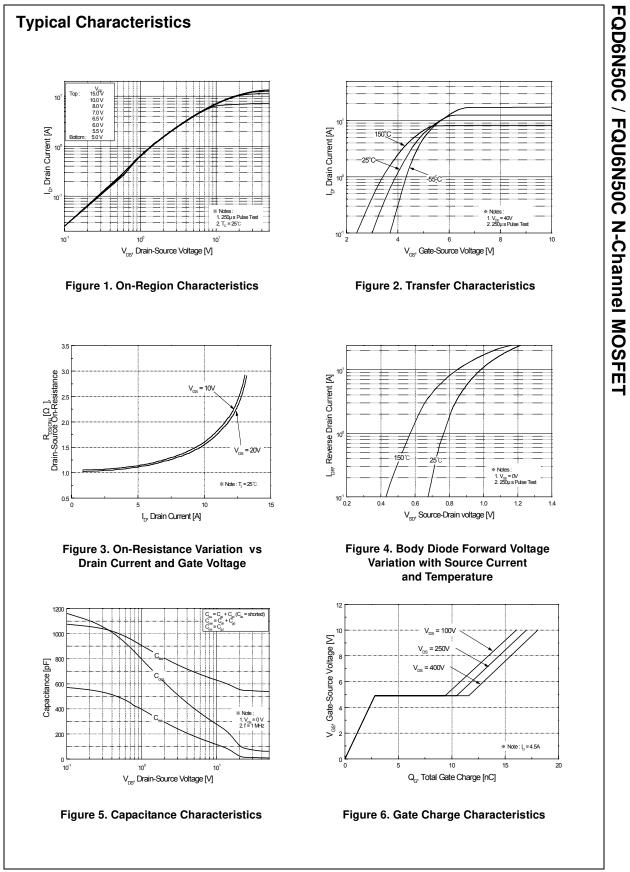
Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter		FQD6N50C / FQU6N50C	Unit
V _{DSS}	Drain-Source Voltage		500	V
I _D	Drain Current - Continuous (T _C = 25	°C)	4.5	А
	- Continuous (T _C = 100°C)		2.7	А
I _{DM}	Drain Current - Pulsed	(Note 1)	18	А
V _{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	300	mJ
I _{AR}	Avalanche Current	(Note 1)	4.5	А
E _{AR}	Repetitive Avalanche Energy	(Note 1)	6.1	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns
	Power Dissipation (T _A = 25°C)*		2.5	W
PD	Power Dissipation (T _C = 25°C)		61	W
	- Derate above 25°C		0.49	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C
TL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

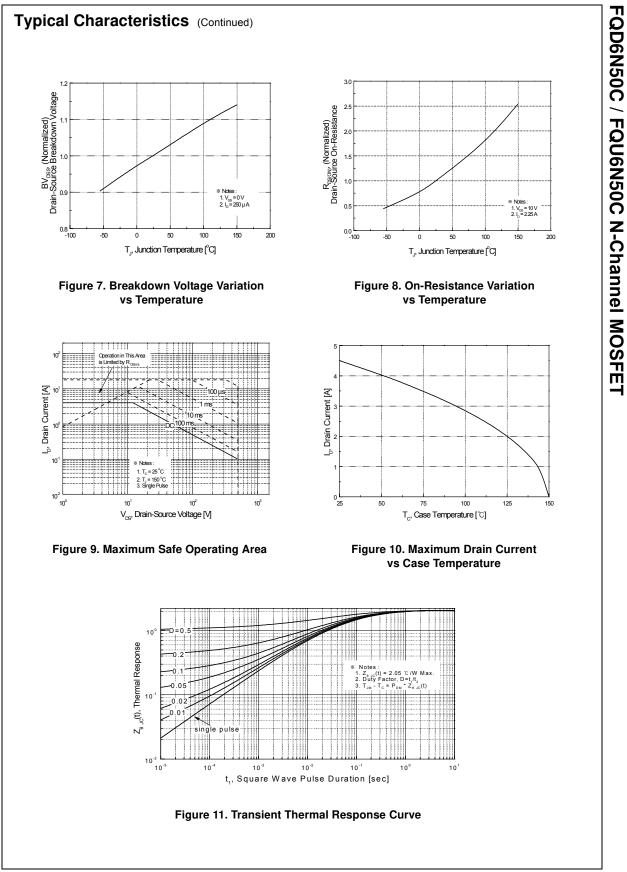
Thermal Characteristics

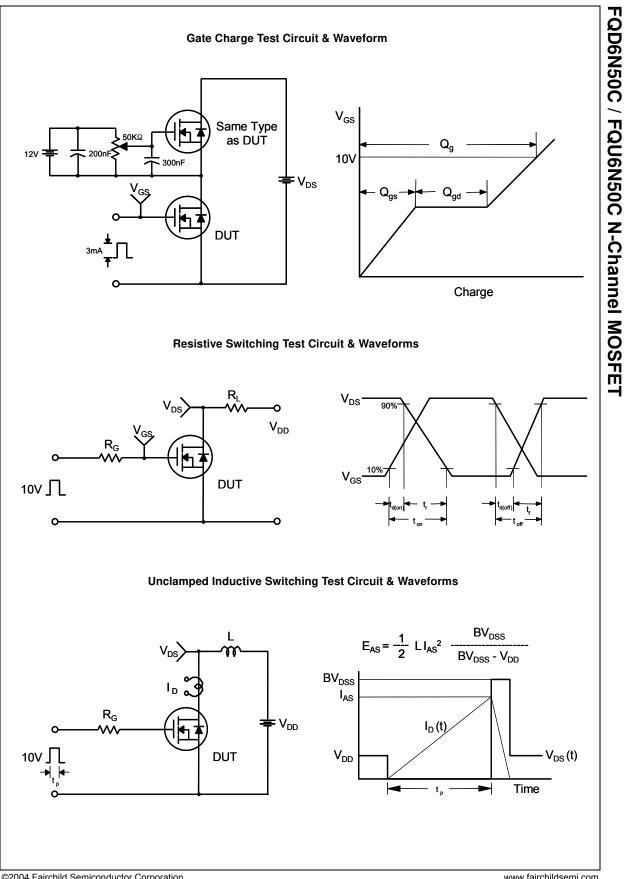
Symbol	Parameter	Тур	Max	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	-	2.05	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *	-	50	°C/W
R _{0JA}	Thermal Resistance, Junction-to-Ambient	-	110	°C/W

	Parameter	Test Conditions	Min	Тур	Max	Unit
Off Cha	racteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 μA	500			V
ΔBV _{DSS} ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = 250 µA, Referenced to 25°C		0.8		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 500 V, V _{GS} = 0 V			1	μA
		V _{DS} = 400 V, T _C = 125°C			10	μA
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V_{GS} = -30 V, V_{DS} = 0 V			-100	nA
On Cha	racteristics					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu\text{A}$	2.0		4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 2.25A	-	1.0	1.2	Ω
9 _{FS}	Forward Transconductance	V _{DS} = 40 V, I _D = 2.25A (Note 4)		4.5		S
Dynam	c Characteristics					
C _{iss}	Input Capacitance	y = 25 y y = 0 y		540	700	pF
C _{OSS}	Output Capacitance	V _{DS} = 25 V, V _{GS} = 0 V, f = 1.0 MHz		80	105	pF
C _{rss}	Reverse Transfer Capacitance			15	20	pF
d(on) r	Turn-On Delay Time Turn-On Rise Time	$V_{DD} = 250 \text{ V}, \text{ I}_{D} = 4.5\text{A},$ R _G = 25 Ω		10 35	30 80	ns ns
-		R _G = 25 Ω		35 55	80 120	-
^t d(off) ^t f	Turn-Off Delay Time Turn-Off Fall Time	(Note 4, 5)		45	100	ns ns
Q _g	Total Gate Charge	V _{DS} = 400 V, I _D = 4.5A,		19	25	nC
∽g Q _{gs}	Gate-Source Charge	$V_{\rm DS} = 400 \text{ V}, I_{\rm D} = 4.5\text{A},$ $V_{\rm GS} = 10 \text{ V}$		2.8		nC
Q _{gd}	Gate-Drain Charge	(Note 4, 5)		8.8		nC
	ource Diode Characteristics ar	nd Maximum Ratings				
Drain-S	Maximum Continuous Drain-Source Dic				4.5	Α
Drain-S I _S					18	Α
s	Maximum Pulsed Drain-Source Diode F	-orward Current				
ls I _{SM}	Maximum Pulsed Drain-Source Diode F Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 4.5 A			1.4	V
				 260	1.4 	V ns

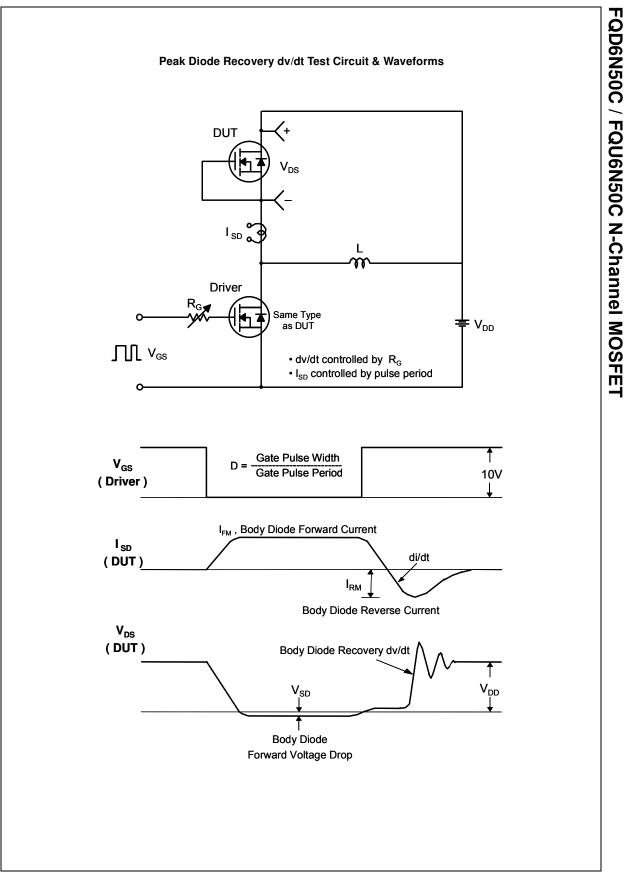


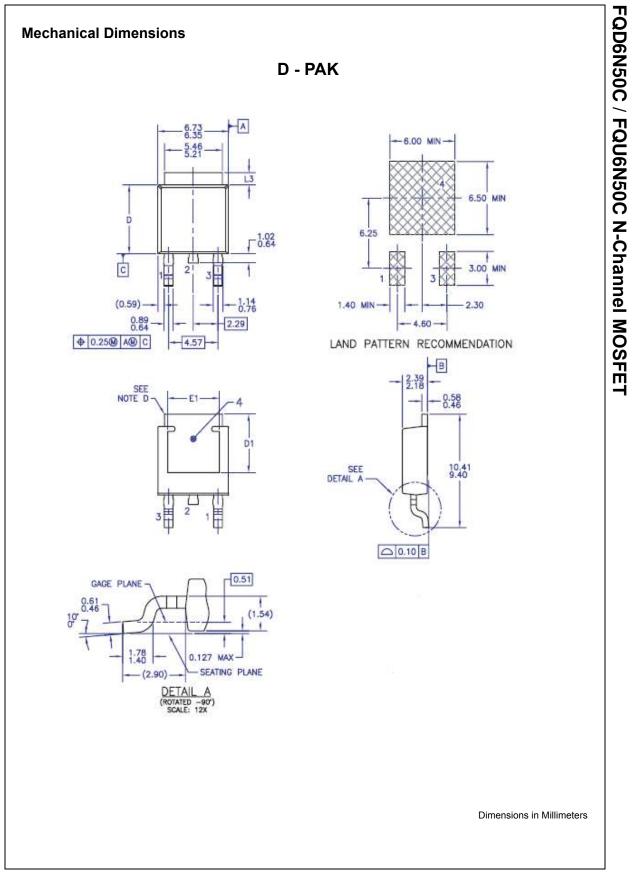
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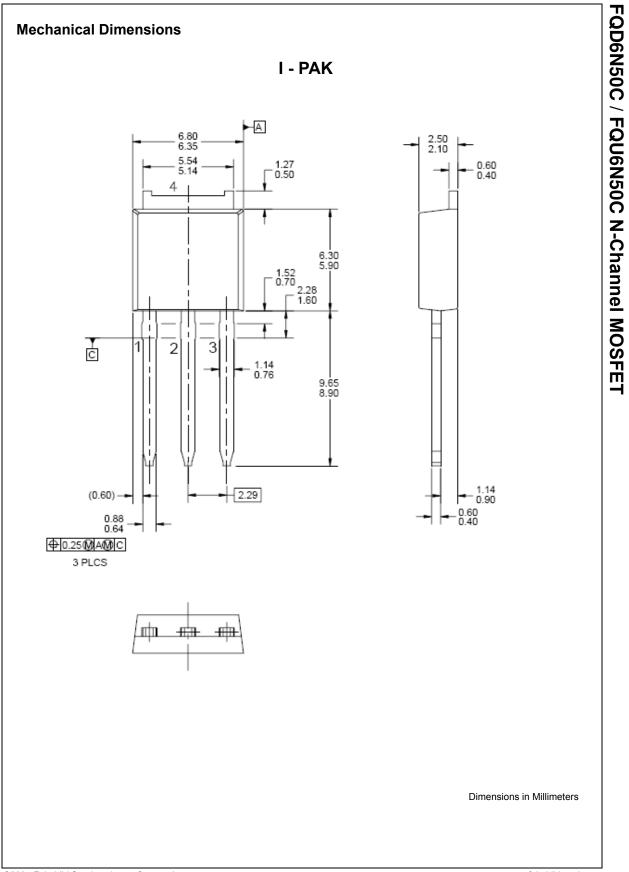


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